Random bad cell map for wafer 178 s/n: Y21316-09-12

Date: 07/09/99

		0	0	0	0			
		0		0		0		
	1		0	4		0		
	0	0	1	7	10			
0	0	0	7	16	11	3	0	0
0			12	26	27	2	0	
0	0	14		23	35	6		1
0	0	9	11	10	26	10	0	0
0		18	8	0	13	16	0	
0		15	8	5	14	6	0	
0	0	12	9		15	8	0	0
0	0	7	18	11	22		0	0
0	0	4	22	12	13	1		0
0	0	0	7	13	7	1	0	5
	0	0	0	3	0		24	
	0	0	39		0	0	0	
		0	0	0	0	0		
		0		0	0	1		

#	Number of bad cells in random locations
	No info